

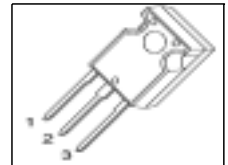
## Cool MOS™ Power Transistor

### Feature

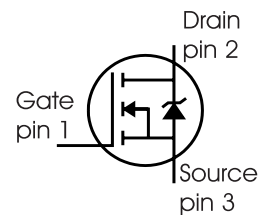
- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme  $dv/dt$  rated
- Ultra low effective capacitances
- Improved transconductance
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>0)</sup> for target applications

|                     |      |          |
|---------------------|------|----------|
| $V_{DS} @ T_{jmax}$ | 650  | V        |
| $R_{DS(on)}$        | 0.28 | $\Omega$ |
| $I_D$               | 15   | A        |

PG-TO247



| Type       | Package  | Ordering Code | Marking |
|------------|----------|---------------|---------|
| SPW15N60C3 | PG-TO247 | Q67040-S4604  | 15N60C3 |



### Maximum Ratings

| Parameter                                                                                                                 | Symbol              | Value       | Unit |
|---------------------------------------------------------------------------------------------------------------------------|---------------------|-------------|------|
| Continuous drain current<br>$T_C = 25\text{ °C}$<br>$T_C = 100\text{ °C}$                                                 | $I_D$               | 15<br>9.4   | A    |
| Pulsed drain current, $t_p$ limited by $T_{jmax}$                                                                         | $I_{D\text{ puls}}$ | 45          |      |
| Avalanche energy, single pulse<br>$I_D = 7.5\text{ A}$ , $V_{DD} = 50\text{ V}$                                           | $E_{AS}$            | 460         | mJ   |
| Avalanche energy, repetitive $t_{AR}$ limited by $T_{jmax}$ <sup>1)</sup><br>$I_D = 15\text{ A}$ , $V_{DD} = 50\text{ V}$ | $E_{AR}$            | 0.8         |      |
| Avalanche current, repetitive $t_{AR}$ limited by $T_{jmax}$                                                              | $I_{AR}$            | 15          | A    |
| Reverse diode $dv/dt$ <sup>4)</sup>                                                                                       | $dv/dt$             | 15          | V/ns |
| Gate source voltage static                                                                                                | $V_{GS}$            | $\pm 20$    | V    |
| Gate source voltage AC ( $f > 1\text{ Hz}$ )                                                                              | $V_{GS}$            | $\pm 30$    |      |
| Power dissipation, $T_C = 25\text{ °C}$                                                                                   | $P_{tot}$           | 156         | W    |
| Operating and storage temperature                                                                                         | $T_j, T_{stg}$      | -55... +150 | °C   |

**Maximum Ratings**

| Parameter                                                                                           | Symbol  | Value | Unit |
|-----------------------------------------------------------------------------------------------------|---------|-------|------|
| Drain Source voltage slope<br>$V_{DS} = 480\text{ V}$ , $I_D = 15\text{ A}$ , $T_j = 125\text{ °C}$ | $dv/dt$ | 50    | V/ns |

**Thermal Characteristics**

| Parameter                                                                    | Symbol     | Values |      |      | Unit |
|------------------------------------------------------------------------------|------------|--------|------|------|------|
|                                                                              |            | min.   | typ. | max. |      |
| Thermal resistance, junction - case                                          | $R_{thJC}$ | -      | -    | 0.8  | K/W  |
| Thermal resistance, junction - ambient, leaded                               | $R_{thJA}$ | -      | -    | 62   |      |
| Soldering temperature, wavesoldering<br>1.6 mm (0.063 in.) from case for 10s | $T_{sold}$ | -      | -    | 260  | °C   |

**Electrical Characteristics, at  $T_j=25\text{ °C}$  unless otherwise specified**

| Parameter                                   | Symbol        | Conditions                                                                                   | Values |      |      | Unit          |
|---------------------------------------------|---------------|----------------------------------------------------------------------------------------------|--------|------|------|---------------|
|                                             |               |                                                                                              | min.   | typ. | max. |               |
| Drain-source breakdown voltage              | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=0.25\text{ mA}$                                                   | 600    | -    | -    | V             |
| Drain-Source avalanche<br>breakdown voltage | $V_{(BR)DS}$  | $V_{GS}=0\text{ V}$ , $I_D=15\text{ A}$                                                      | -      | 700  | -    |               |
| Gate threshold voltage                      | $V_{GS(th)}$  | $I_D=675\text{ }\mu\text{A}$ , $V_{GS}=V_{DS}$                                               | 2.1    | 3    | 3.9  |               |
| Zero gate voltage drain current             | $I_{DSS}$     | $V_{DS}=600\text{ V}$ , $V_{GS}=0\text{ V}$ ,<br>$T_j=25\text{ °C}$ ,<br>$T_j=150\text{ °C}$ | -      | 0.1  | 1    | $\mu\text{A}$ |
|                                             |               |                                                                                              | -      | -    | 100  |               |
| Gate-source leakage current                 | $I_{GSS}$     | $V_{GS}=30\text{ V}$ , $V_{DS}=0\text{ V}$                                                   | -      | -    | 100  | nA            |
| Drain-source on-state resistance            | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=9.4\text{ A}$ ,<br>$T_j=25\text{ °C}$<br>$T_j=150\text{ °C}$     | -      | 0.25 | 0.28 | $\Omega$      |
|                                             |               |                                                                                              | -      | 0.68 | -    |               |
| Gate input resistance                       | $R_G$         | $f=1\text{ MHz}$ , open Drain                                                                | -      | 1.23 | -    |               |

**Electrical Characteristics** , at  $T_j = 25\text{ }^{\circ}\text{C}$ , unless otherwise specified

| Parameter                                                     | Symbol       | Conditions                                                                                   | Values |      |      | Unit |
|---------------------------------------------------------------|--------------|----------------------------------------------------------------------------------------------|--------|------|------|------|
|                                                               |              |                                                                                              | min.   | typ. | max. |      |
| Transconductance                                              | $g_{fs}$     | $V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ ,<br>$I_D = 9.4\text{A}$                       | -      | 11.9 | -    | S    |
| Input capacitance                                             | $C_{iss}$    | $V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ ,<br>$f = 1\text{MHz}$                          | -      | 1660 | -    | pF   |
| Output capacitance                                            | $C_{oss}$    |                                                                                              | -      | 540  | -    |      |
| Reverse transfer capacitance                                  | $C_{rss}$    |                                                                                              | -      | 40   | -    |      |
| Effective output capacitance, <sup>2)</sup><br>energy related | $C_{o(er)}$  | $V_{GS} = 0\text{V}$ ,<br>$V_{DS} = 0\text{V to } 480\text{V}$                               | -      | 80   | -    | pF   |
| Effective output capacitance, <sup>3)</sup><br>time related   | $C_{o(tr)}$  |                                                                                              | -      | 127  | -    |      |
| Turn-on delay time                                            | $t_{d(on)}$  | $V_{DD} = 380\text{V}$ , $V_{GS} = 0/10\text{V}$ ,<br>$I_D = 15\text{A}$ , $R_G = 4.3\Omega$ | -      | 10   | -    | ns   |
| Rise time                                                     | $t_r$        |                                                                                              | -      | 5    | -    |      |
| Turn-off delay time                                           | $t_{d(off)}$ |                                                                                              | -      | 50   | 80   |      |
| Fall time                                                     | $t_f$        |                                                                                              | -      | 5    | 10   |      |

**Gate Charge Characteristics**

|                       |                 |                                                                                     |   |    |   |    |
|-----------------------|-----------------|-------------------------------------------------------------------------------------|---|----|---|----|
| Gate to source charge | $Q_{gs}$        | $V_{DD} = 480\text{V}$ , $I_D = 15\text{A}$                                         | - | 7  | - | nC |
| Gate to drain charge  | $Q_{gd}$        |                                                                                     | - | 29 | - |    |
| Gate charge total     | $Q_g$           | $V_{DD} = 480\text{V}$ , $I_D = 15\text{A}$ ,<br>$V_{GS} = 0\text{ to } 10\text{V}$ | - | 63 | - |    |
| Gate plateau voltage  | $V_{(plateau)}$ | $V_{DD} = 480\text{V}$ , $I_D = 15\text{A}$                                         | - | 5  | - | V  |

<sup>0</sup>J-STD20 and JESD22

<sup>1</sup>Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV} = E_{AR} \cdot f$ .

<sup>2</sup> $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>3</sup> $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>4</sup> $I_{SD} \leq I_D$ ,  $di/dt \leq 400\text{A/us}$ ,  $V_{DClink} = 400\text{V}$ ,  $V_{peak} < V_{BR, DSS}$ ,  $T_j < T_{j,max}$ .

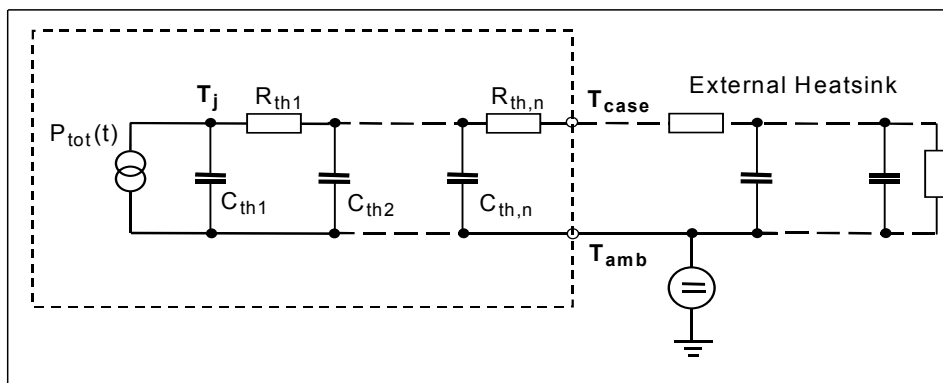
Identical low-side and high-side switch.

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                     | Symbol       | Conditions                                                  | Values |      |      | Unit                   |
|-----------------------------------------------|--------------|-------------------------------------------------------------|--------|------|------|------------------------|
|                                               |              |                                                             | min.   | typ. | max. |                        |
| Inverse diode continuous forward current      | $I_S$        | $T_C=25^\circ\text{C}$                                      | -      | -    | 15   | A                      |
| Inverse diode direct current, pulsed          | $I_{SM}$     |                                                             | -      | -    | 45   |                        |
| Inverse diode forward voltage                 | $V_{SD}$     | $V_{GS}=0\text{V}, I_F=I_S$                                 | -      | 1    | 1.2  | V                      |
| Reverse recovery time                         | $t_{rr}$     | $V_R=480\text{V}, I_F=I_S, di_F/dt=100\text{A}/\mu\text{s}$ | -      | 460  | -    | ns                     |
| Reverse recovery charge                       | $Q_{rr}$     |                                                             | -      | 27   | -    | $\mu\text{C}$          |
| Peak reverse recovery current                 | $I_{rrm}$    |                                                             | -      | 55   | -    | A                      |
| Peak rate of fall of reverse recovery current | $di_{rr}/dt$ |                                                             | -      | tbd  | -    | $\text{A}/\mu\text{s}$ |

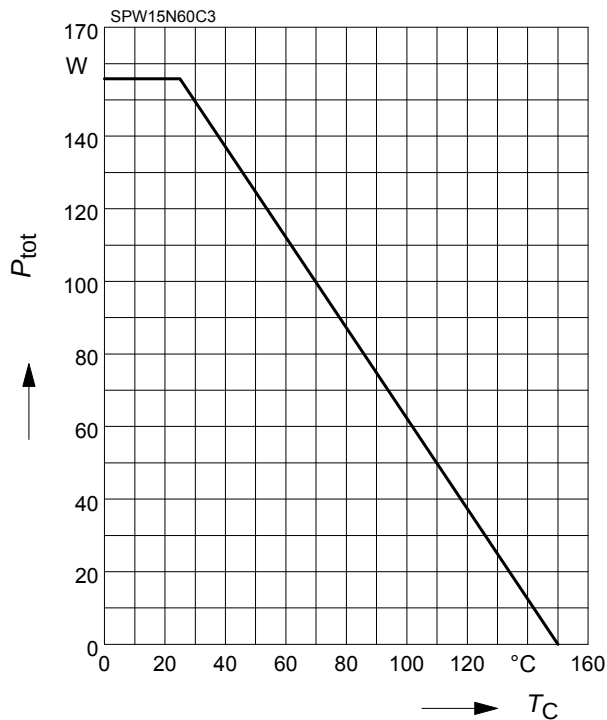
### Typical Transient Thermal Characteristics

| Symbol             | Value | Unit | Symbol              | Value     | Unit |
|--------------------|-------|------|---------------------|-----------|------|
|                    | typ.  |      |                     | typ.      |      |
| Thermal resistance |       |      | Thermal capacitance |           |      |
| $R_{th1}$          | 0.012 | K/W  | $C_{th1}$           | 0.0002495 | Ws/K |
| $R_{th2}$          | 0.023 |      | $C_{th2}$           | 0.0009406 |      |
| $R_{th3}$          | 0.043 |      | $C_{th3}$           | 0.001298  |      |
| $R_{th4}$          | 0.156 |      | $C_{th4}$           | 0.00362   |      |
| $R_{th5}$          | 0.178 |      | $C_{th5}$           | 0.009046  |      |
| $R_{th6}$          | 0.072 |      | $C_{th6}$           | 0.412     |      |



### 1 Power dissipation

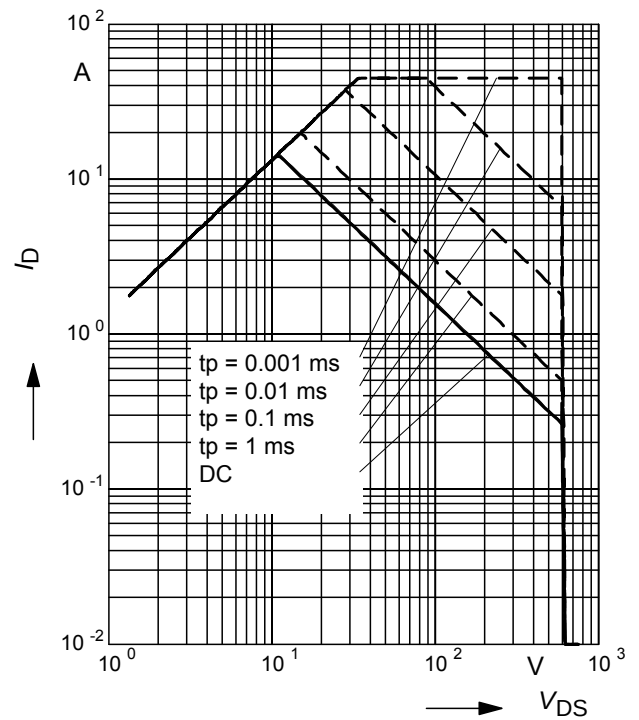
$$P_{\text{tot}} = f(T_C)$$



### 2 Safe operating area

$$I_D = f(V_{DS})$$

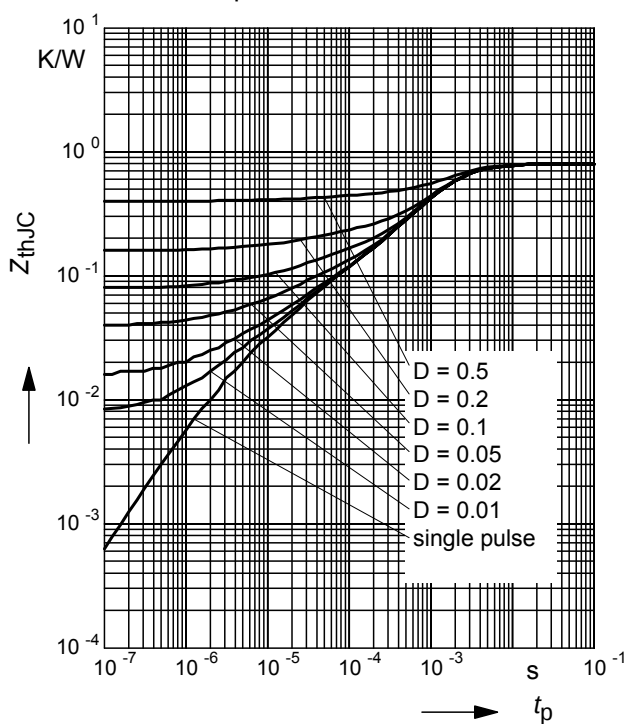
parameter :  $D = 0$  ,  $T_C = 25^\circ\text{C}$



### 3 Transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

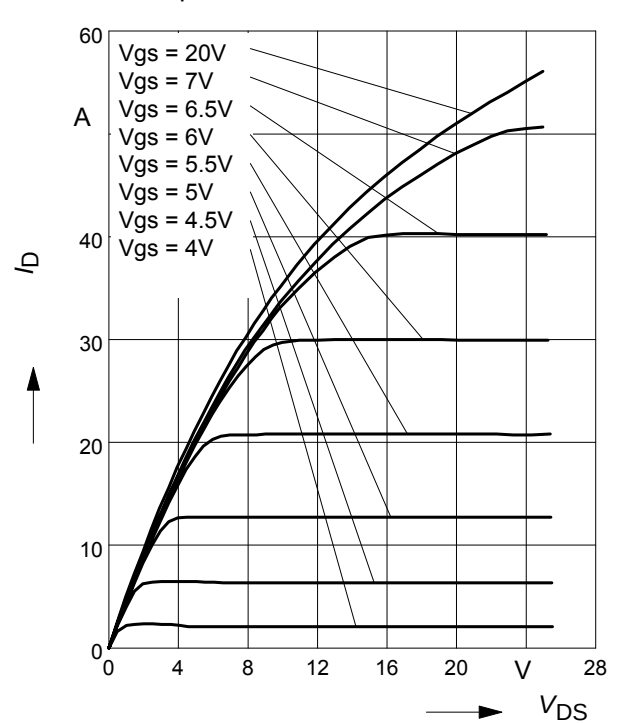
parameter:  $D = t_p/T$



### 4 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$$

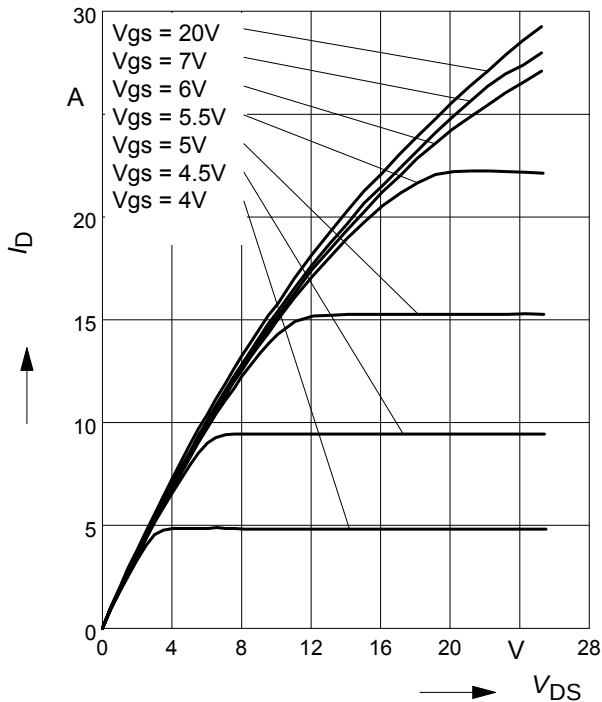
parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



### 5 Typ. output characteristic

$$I_D = f(V_{DS}); T_j = 150^\circ\text{C}$$

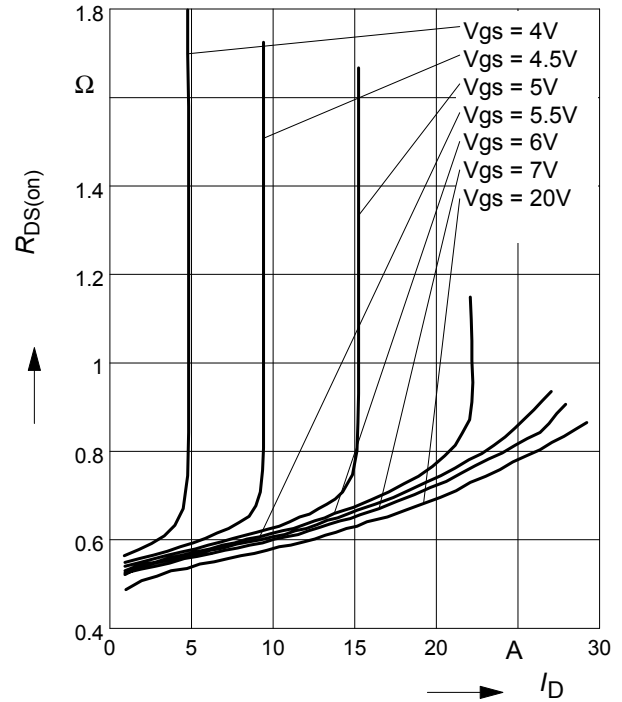
parameter:  $t_p = 10 \mu\text{s}$ ,  $V_{GS}$



### 6 Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$

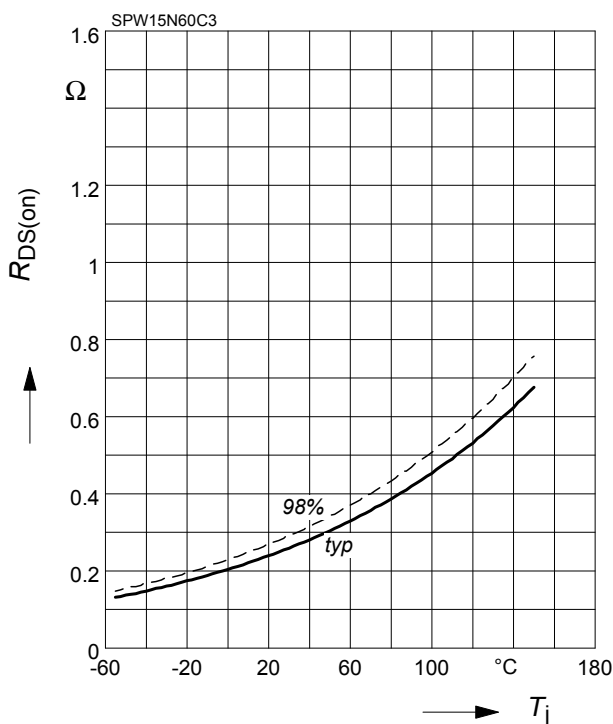
parameter:  $T_j = 150^\circ\text{C}$ ,  $V_{GS}$



### 7 Drain-source on-state resistance

$$R_{DS(on)} = f(T_j)$$

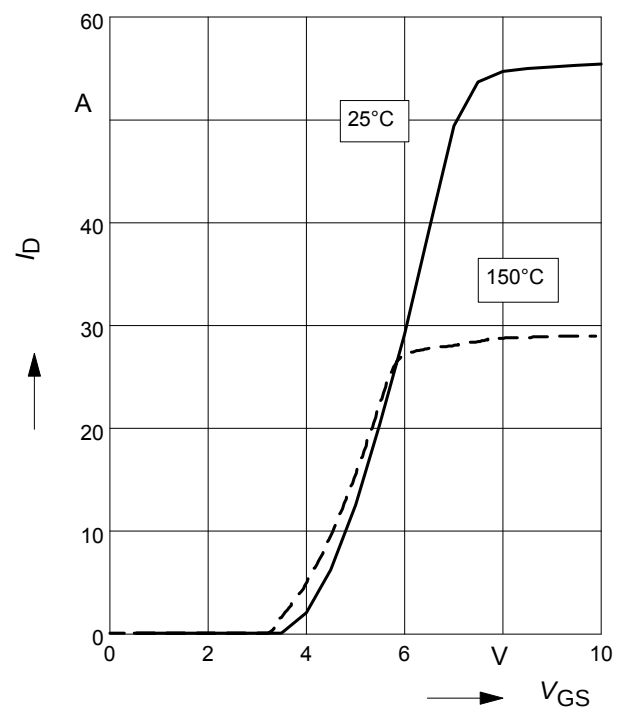
parameter:  $I_D = 9.4 \text{ A}$ ,  $V_{GS} = 10 \text{ V}$



### 8 Typ. transfer characteristics

$$I_D = f(V_{GS}); V_{DS} \geq 2 \times I_D \times R_{DS(on)\text{max}}$$

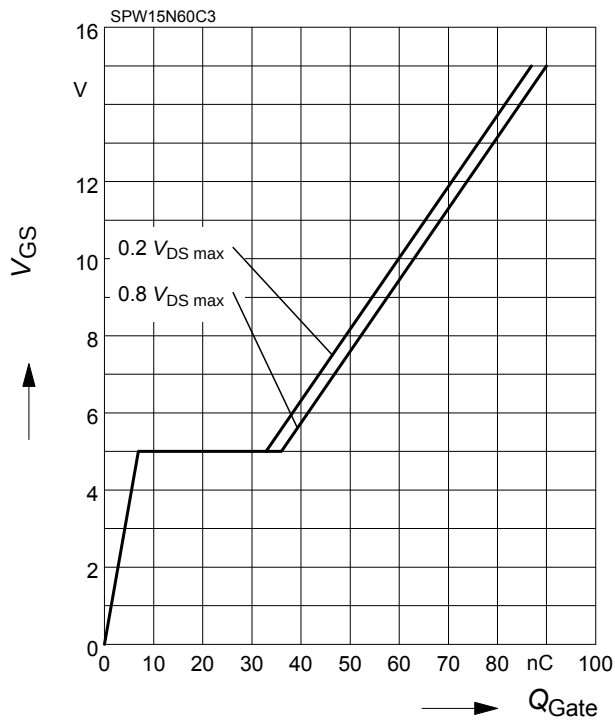
parameter:  $t_p = 10 \mu\text{s}$



## 9 Typ. gate charge

$$V_{GS} = f(Q_{Gate})$$

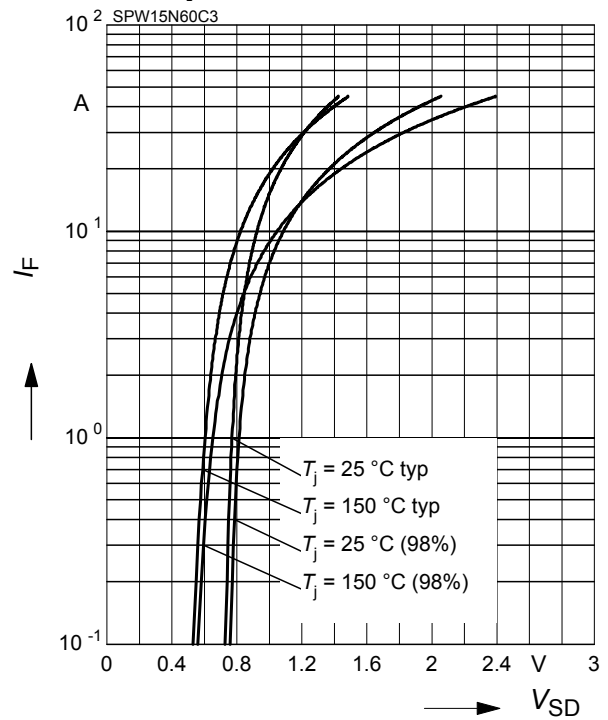
parameter:  $I_D = 15\text{ A}$  pulsed



## 10 Forward characteristics of body diode

$$I_F = f(V_{SD})$$

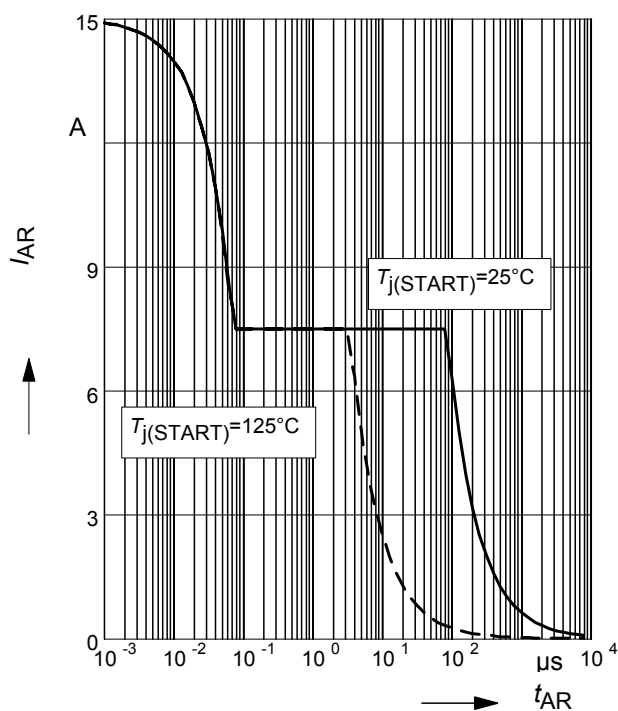
parameter:  $T_j$ ,  $t_p = 10\text{ }\mu\text{s}$



## 11 Avalanche SOA

$$I_{AR} = f(t_{AR})$$

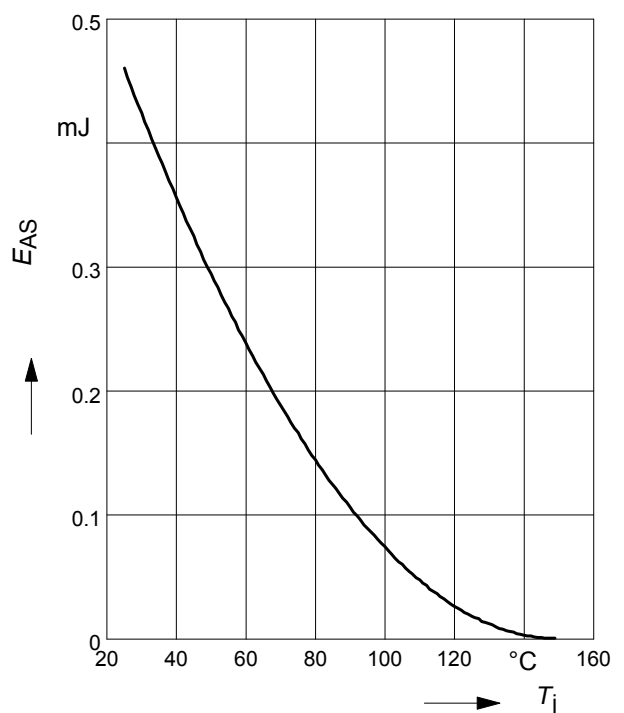
par.:  $T_j \leq 150\text{ }^\circ\text{C}$



## 12 Avalanche energy

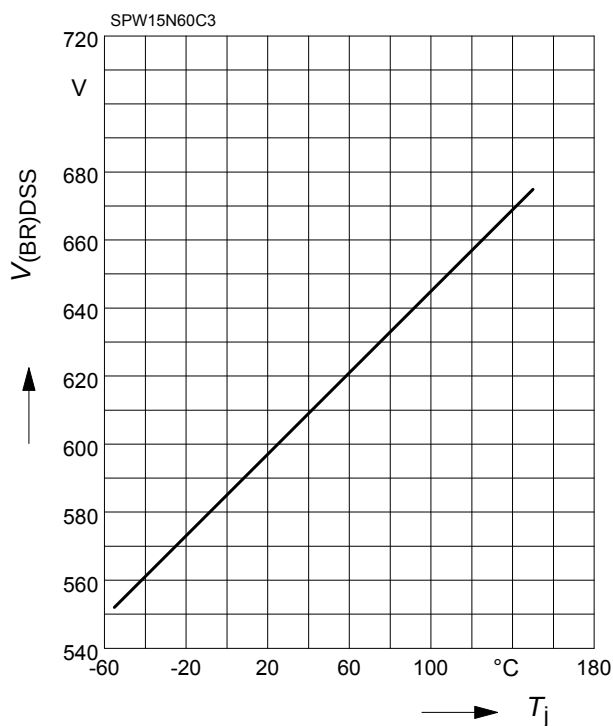
$$E_{AS} = f(T_j)$$

par.:  $I_D = 7.5\text{ A}$ ,  $V_{DD} = 50\text{ V}$



### 13 Drain-source breakdown voltage

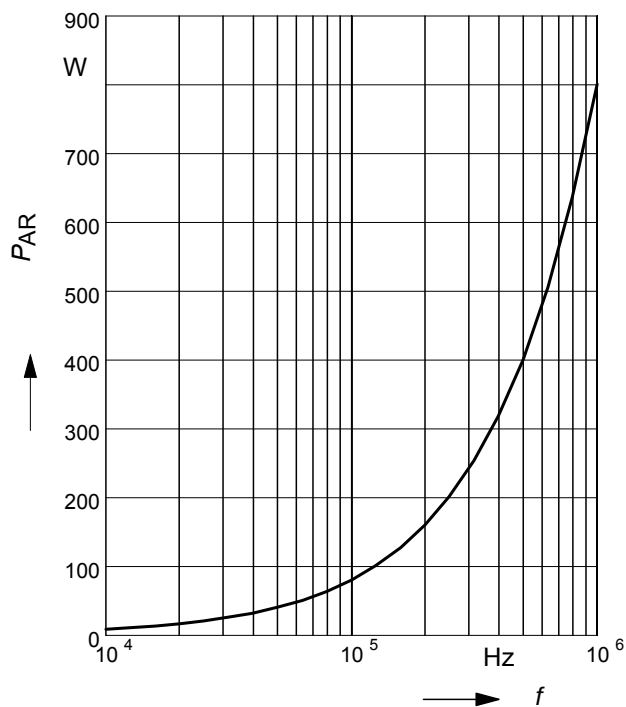
$$V_{(BR)DSS} = f(T_j)$$



### 14 Avalanche power losses

$$P_{AR} = f(f)$$

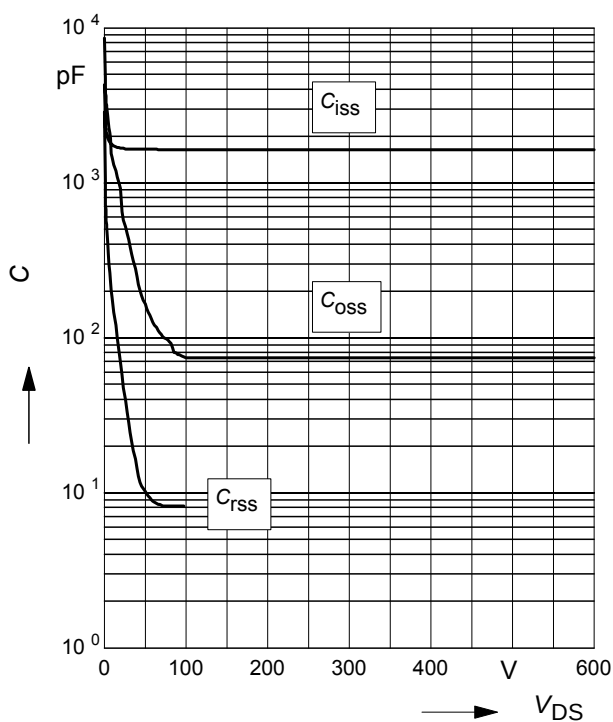
parameter:  $E_{AR}=0.8\text{mJ}$



### 15 Typ. capacitances

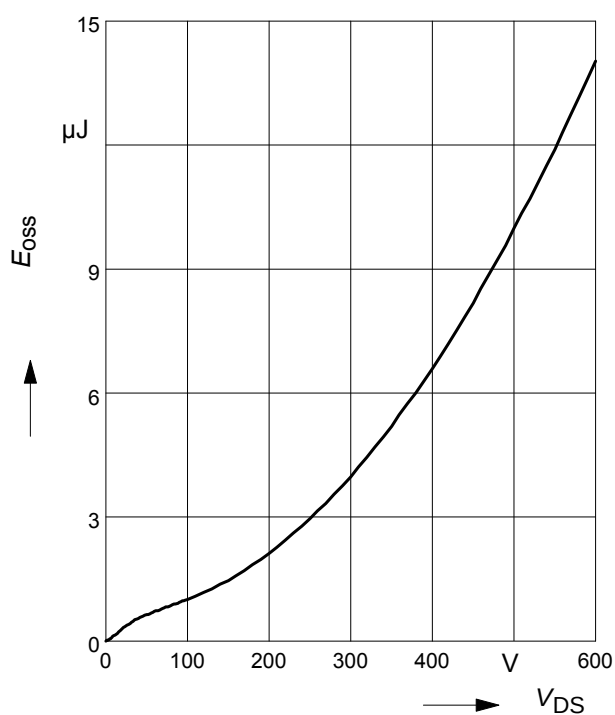
$$C = f(V_{DS})$$

parameter:  $V_{GS}=0\text{V}$ ,  $f=1\text{ MHz}$



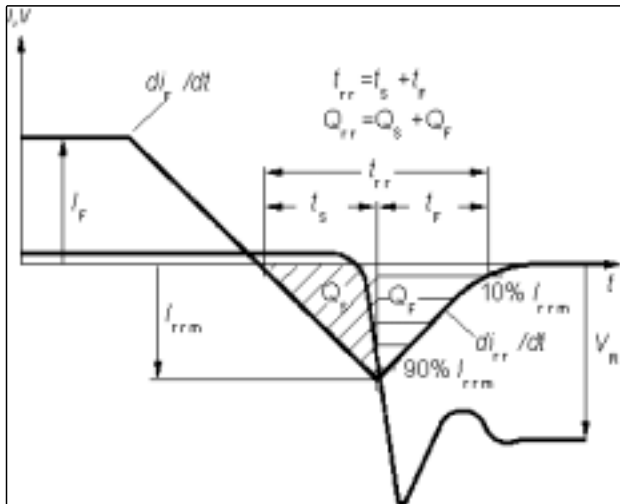
### 16 Typ. $C_{OSS}$ stored energy

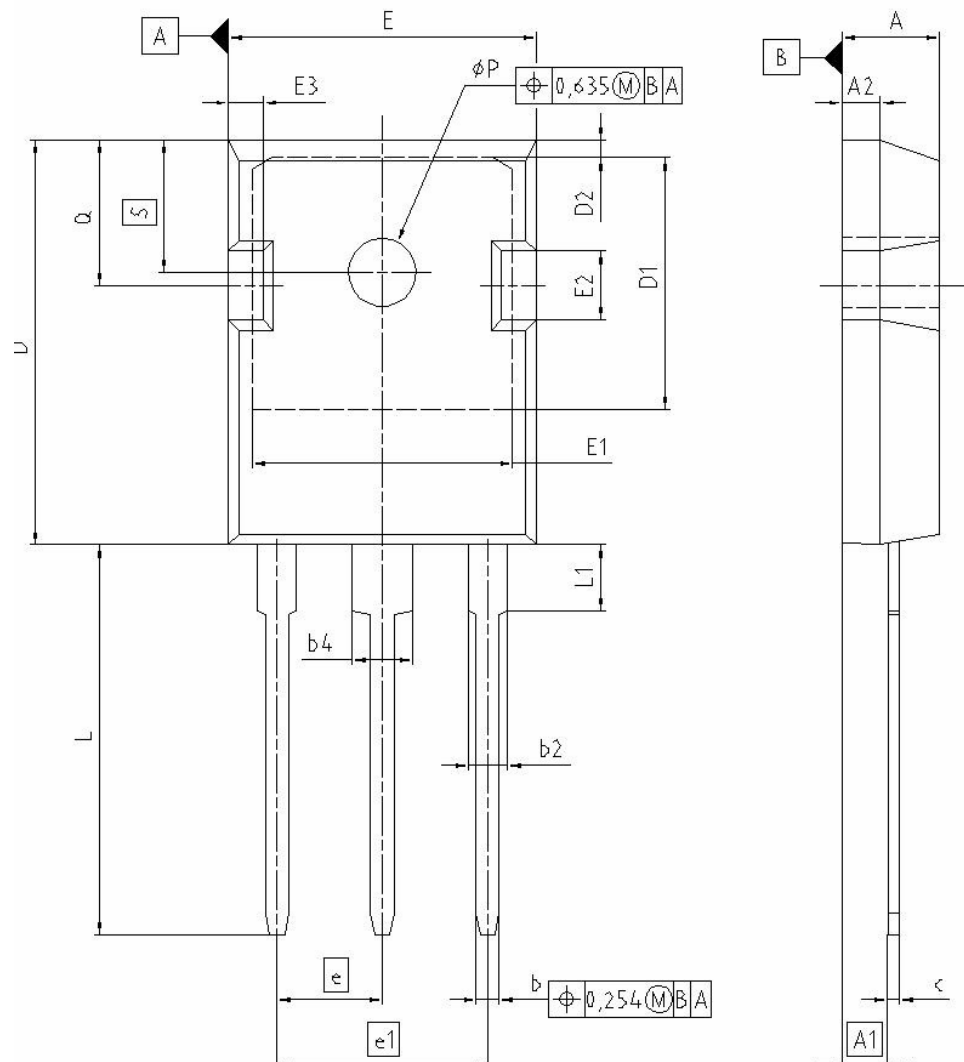
$$E_{oss}=f(V_{DS})$$



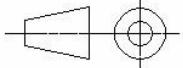


## Definition of diodes switching characteristics



**PG-TO-247-3-1**


| DIM          | MILLIMETERS |        | INCHES |       |
|--------------|-------------|--------|--------|-------|
|              | MIN         | MAX    | MIN    | MAX   |
| <b>A</b>     | 4.903       | 5.157  | 0.193  | 0.203 |
| <b>A1</b>    | 2.273       | 2.527  | 0.092  | 0.096 |
| <b>A2</b>    | 1.853       | 2.107  | 0.075  | 0.081 |
| <b>b</b>     | 1.073       | 1.327  | 0.047  | 0.052 |
| <b>b2</b>    | 1.903       | 2.386  | 0.075  | 0.094 |
| <b>b4</b>    | 2.870       | 3.454  | 0.113  | 0.136 |
| <b>c</b>     | 0.549       | 0.752  | 0.024  | 0.030 |
| <b>D</b>     | 20.823      | 21.077 | 0.820  | 0.830 |
| <b>D1</b>    | 17.323      | 17.831 | 0.682  | 0.702 |
| <b>D2</b>    | 1.063       | 1.317  | 0.042  | 0.052 |
| <b>E</b>     | 15.773      | 16.027 | 0.621  | 0.631 |
| <b>E1</b>    | 13.893      | 14.147 | 0.547  | 0.557 |
| <b>E2</b>    | 3.683       | 3.937  | 0.145  | 0.155 |
| <b>E3</b>    | 1.683       | 1.937  | 0.066  | 0.076 |
| <b>e</b>     | 5.450       |        | 0.215  |       |
| <b>e1</b>    | 10.900      |        | 0.430  |       |
| <b>N</b>     | 3           |        | 3      |       |
| <b>L</b>     | 20.053      | 20.307 | 0.789  | 0.799 |
| <b>L1</b>    | 4.168       | 4.472  | 0.164  | 0.176 |
| <b>phi P</b> | 3.559       | 3.661  | 0.140  | 0.144 |
| <b>Q</b>     | 5.493       | 5.747  | 0.216  | 0.226 |
| <b>S</b>     | 6.043       | 6.297  | 0.238  | 0.248 |

|                                                                                                                     |
|---------------------------------------------------------------------------------------------------------------------|
| <b>REFERENCE</b><br>JEDEC TO247-AD                                                                                  |
| <b>SCALE</b><br>0 5 5 7.5mm                                                                                         |
| <b>EUROPEAN PROJECTION</b><br> |
| <b>ISSUE DATE</b><br>28-06-2005                                                                                     |
| <b>FILE</b><br>TO247_1                                                                                              |

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